infineon

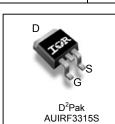
AUIRF3315S

Features

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V_{DSS}

 I_D

R_{DS(on)} max.

G	D	S
Gate	Drain	Source

Bass part number	Deekege Type	Standard Pack		Ordershie Port Number
Base part number	Package Type	Form Quantity Ordera		Orderable Part Number
AUIRF3315S	D ² -Pak	Tube	50	AUIRF3315S
AUIRE33135	D-rak	Tape and Reel Left	800	AUIRF3315STRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	21	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	15	A
I _{DM}	Pulsed Drain Current ①	84	
$P_D @T_A = 25^{\circ}C$ Maximum Power Dissipation		3.8	
P _D @T _C = 25°C	Maximum Power Dissipation	94	- W
	Linear Derating Factor		W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) 2		350	mJ
I _{AR} Avalanche Current ①		12	A
E _{AR}	Repetitive Avalanche Energy	9.4	mJ
dv/dt	Peak Diode Recovery 3	2.5	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case®		1.6	°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount, steady state) (5)		40	C/VV

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*Qualification standards can be found at www.infineon.com

150V

82mΩ

21A

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	150			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.187		V/°C	Reference to 25° C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			82	mΩ	V _{GS} = 10V, I _D = 12A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _D = 250μA
1	Drain to Source Leokage Current			25	μA	V _{DS} = 150V, V _{GS} = 0V
DSS	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 120V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	~ ^	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

,				,		
Qg	Total Gate Charge			95		I _D = 12A
Q _{gs}	Gate-to-Source Charge			11	nC	V _{DS} = 120V
Q _{gd}	Gate-to-Drain Charge			47		V _{GS} = 10V④
t _{d(on)}	Turn-On Delay Time		9.6			V _{DD} = 75V
t _r	Rise Time		32		ns	I _D = 12A
t _{d(off)}	Turn-Off Delay Time		49		115	R _G = 5.1Ω,
t _f	Fall Time		38			R _D = 5.9Ω, ④
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
L _s	Internal Source Inductance		7.5			from package and center of die contact
C _{iss}	Input Capacitance		1300			V _{GS} = 0V
C _{oss}	Output Capacitance		300		pF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		160			f = 1.0MHz, See Fig.5
Diode Ch	aracteristics			•	•	
	Parameter	Min.	Тур.	Max.	Units	Conditions
s	Continuous Source Current (Body Diode)			21		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			84		integral reverse $\operatorname{equation}$
V _{SD}	Diode Forward Voltage			1.3	V	$T_{J} = 25^{\circ}C, I_{S} = 12A, V_{GS} = 0V @$
t _{rr}	Reverse Recovery Time		174	260	ns	T _J = 25°C ,I _F = 12A
Q _{rr}	Reverse Recovery Charge		1.2	1.7	μC	di/dt = 100A/µs ④

Notes:

t_{on}

① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)

⁽²⁾ Limited by T_{Jmax} , starting $T_J = 25^{\circ}$ C, L = 4.9mH, $R_G = 25\Omega$, $I_{AS} = 12A$. (See fig. 12)

Forward Turn-On Time

④ Pulse width \leq 300µs; duty cycle \leq 2%.

S When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

Intrinsic turn-on time is negligible (turn-on is dominated by $L_{s}+L_{D}$)

 $\label{eq:rescaled} \begin{tabular}{ll} \hline & R_\theta \mbox{ is measured at } T_J \mbox{ of approximately } 90^\circ C \end{tabular}$



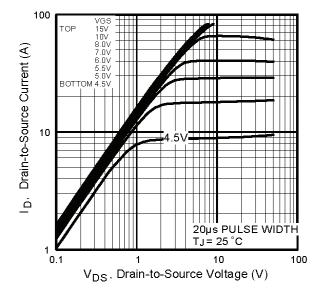


Fig. 1 Typical Output Characteristics

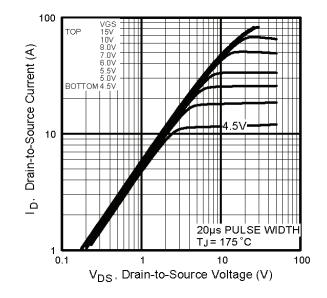


Fig. 2 Typical Output Characteristics

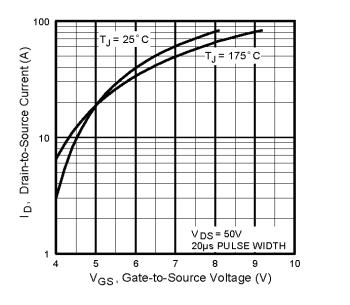


Fig. 3 Typical Transfer Characteristics

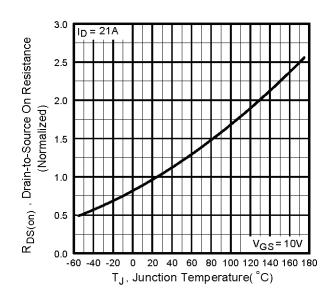


Fig. 4 Normalized On-Resistance vs. Temperature



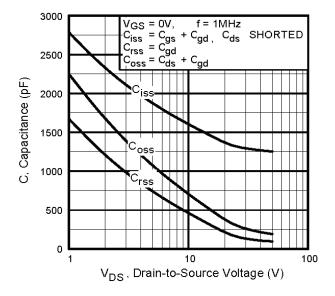


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

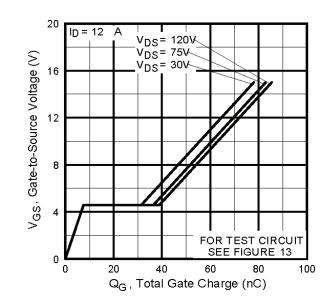


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

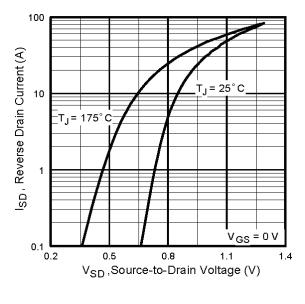


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

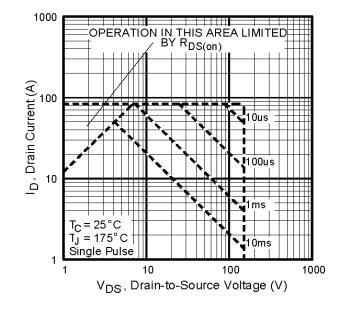
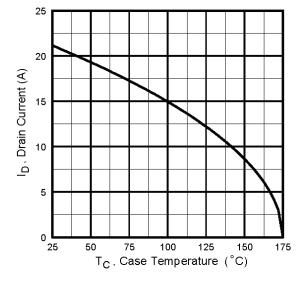
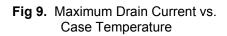


Fig 8. Maximum Safe Operating Area







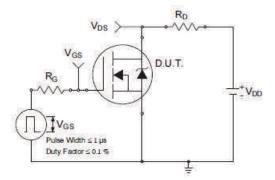


Fig 10a. Switching Time Test Circuit

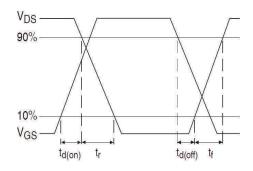


Fig 10b. Switching Time Waveforms

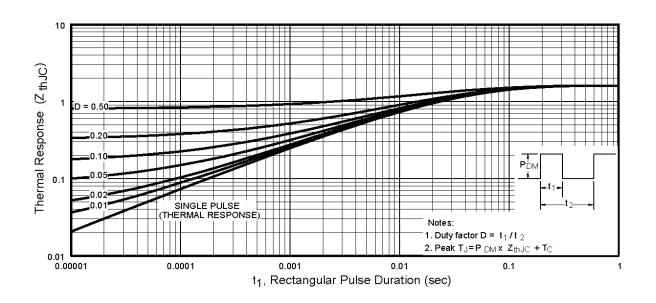


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

тор

воттом

۱D

4.9A

8.5A

12A

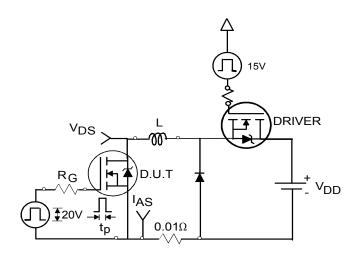


Fig 12a. Unclamped Inductive Test Circuit

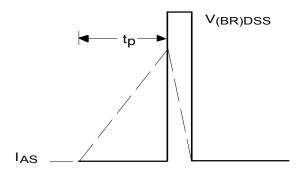


Fig 12c. Maximum Avalanche Energy vs. Drain Current

50

75

100

Starting T_J , Junction Temperature (°C)

125

150

175

1000

800

600

400

200

0 L 25

 E_{AS} , Single Pulse Avalanche Energy (mJ)

Fig 12b. Unclamped Inductive Waveforms

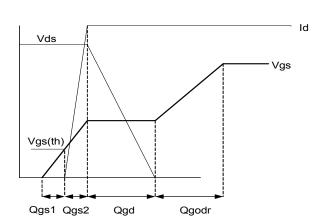


Fig 13a. Gate Charge Waveform

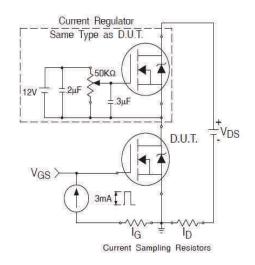


Fig 13b. Gate Charge Test Circuit



Peak Diode Recovery dv/dt Test Circuit

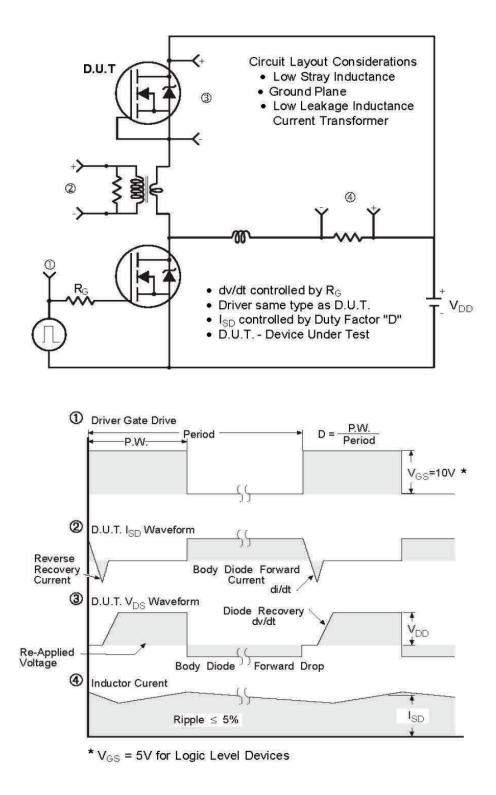
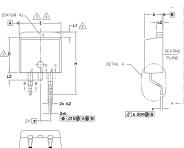


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

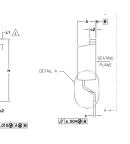


AUIRF3315S

D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))



AD TIF



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

PLATING BASE WETA
ROTATED 90° CW SCALE 8:1

S Y M		DIMEN	SIONS		N
	MILLIM	ETERS	INC	HES	O T E S
B O L	MIN.	MAX.	MIN.	MAX.	E S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	—	4
Е	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	—	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
∟1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

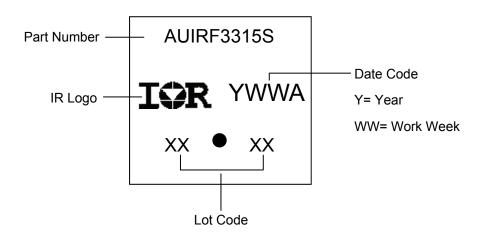
HEXFET

DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

> IGBTS, COPACK 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

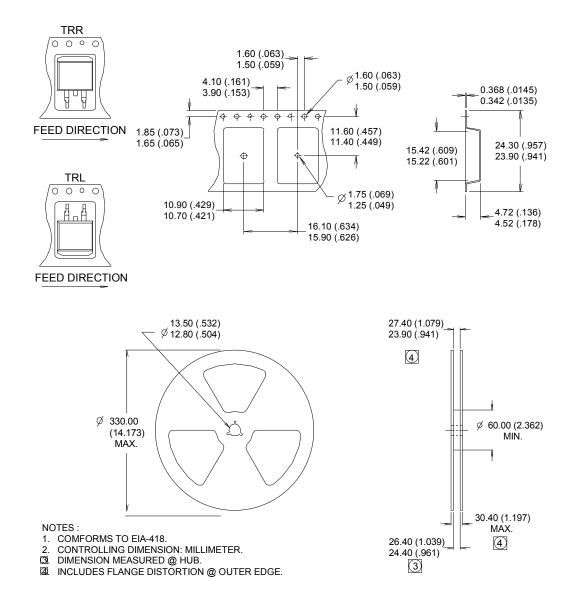


D²Pak (TO-263AB) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Qualification Information

			Automotive (per AEC-Q101)		
Qualification Level Comments: This part number(s) passed Automotive qualification. Industrial and Consumer qualification level is granted by extension of t Automotive level.					
Moisture S	ure Sensitivity Level D ² -Pak MSL1				
	Machine Model	Class M4 (+/- 600V) [†] AEC-Q101-002			
ESD	Human Body Model	Class H1C (+/- 2000V) [†] AEC-Q101-001			
	Charged Device Model	Class C5 (+/- 2000V) [†] AEC-Q101-005			
RoHS Com	pliant	Yes			

+ Highest passing voltage.

Revision History

Date	Comments
11/13/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Corrected typo in test condition current from "43A" to "12A" for VSD and trr/Qrr on page 2.

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